## Issue Classification

CLASS

**ORIGINAL** 

10667753

WANG ET AL.

INTERNATIONAL CLASSIFICATION

Applicant(s)/Patent Under Reexamination

NON-CLAIMED

**Examiner** 

**Art Unit** 

Smith, Marcus

**SUBCLASS** 

2619

CLAIMED

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Marcus Smith (Assistant Examiner)			2/26/08 (Date)		CHAU NGUYEN SUPERVISORY PATENT EX TECHNOLOGY CENTER					T EXAMINER	Total Claims Allowed:				
(Primary Examiner) Chan T. Afreyer											O.G. Print Claim(s)				O.G. Print Figur